## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination AOKI ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,947,158	09-2005	Kitamura et al.	358/1.15
*	В	US-2003/0085942	05-2003	Narusawa et al.	347/19
*	O	US-2002/0054350	05-2002	Kakigi et al.	358/1.16
*	D	US-2005/0275872	12-2005	Otsuki, Koichi	358/001.15
*	Е	US-2003/0103221	06-2003	Natori, Hideo	358/1.9
*	F	US-2004/0080778	04-2004	Ito et al.	358/001.14
*	G	US-2004/0049741	03-2004	Natori, Hideo	715/527
	Ξ	US-			
	_	US-			•
	7	US-			
	K	US-			
	٦	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					·
	Р				·	
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
·	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.